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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/974,608	EBIHARA ET AL.	
Examiner	Art Unit	
Hau H. Nguyen	2628	

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Class	Subclass	Date	Examiner
345	506, 535, 520	12/18/2006	HN
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			484

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
345	506, 535	12/18/2006	HN
	520		
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